

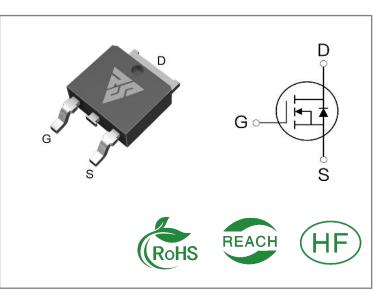
ID	R _{Ds} (ON)(Typ)	VDSS
180A	2.0mΩ	30V

Applications:

- Load Switch
- PWM Applications
- Power Managment

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS30N180D	T0-252	RS30N180D	Tape&reel	2500 PCS

Absolute Maximun Ratings Tc= 25° C unless otherwise specified

Symbol	Parameter	R\$30N180D	Units
VDSS	Drain-to-Source Voltage	30	V
ID	Continuous Drain Current TC=25°C	180	
ID	Continuous Drain Current TC=100 $^\circ\!\!\!\!^\circ$	114	А
IDM	Pulsed Drain Current	720	
PD	Power Dissipation	80	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 0.5mH,VDD = 15V, RG = 25Ω, Tj = 25℃	305	mJ
	Maximum Temperature for Soldering	300	
TL TPKG	TPKG Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds		C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS30N180D	Units	Test Conditions
RθJC	Junction-to-Case	2.1	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ C$
RθJA	Junction-to- Ambient	35		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage 30		V	VGS=0V,ID=250μ Α		
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=30V,VGS=0 V
IGSS	Gate- to- Source Forward Leakage			100	^	VGS=20V ,VDS=0 V
	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance		2.0	3.0	mΩ	VGS=10V,ID=30A
			3.3	4.3	mΩ	VGS=4.5V,ID=20 A
VGS(TH)	Gate Threshold Voltage	1.3	1.9	2.5	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		16			
trise	Rise Time		30			VDS=15V ID=30A
td(OFF)	Turn- OFF Delay Time		52		nS	RG=3Ω VGS=10V
tfall	Fall Time		20			VG3-10V



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
Ciss	Input Capacitance		5060			VGS= 0V	
Coss	Output Capacitance		570		pF	VDS=15V	
Crss	Reverse Transfer Capacitance		470			f=1.0MHz	
Qg	Total Gate Charge		75			VDS= 15V	
Qgs	Gate- to- Source Charge		9		nC	ID=20A	
Qgd	Gate-to-Drain(" Miller") Charge		18			VGS=10V	

Source- Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			180	А	Integral pn- diode	
ISM	Maximum Pulsed Current			720	Α	in MOSFET	
VSD	Diode Forward Voltage			1.2	V	IS=30A,VGS=0V	
trr	Reverse Recovery Time		24		nS	VGS=0V	
Qrr	Reverse Recovery Charge		14		nC	IS=30A di/dt=100A/μs	

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%



Typical Feature Curve

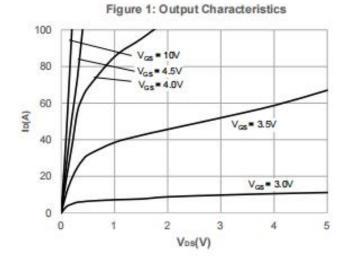
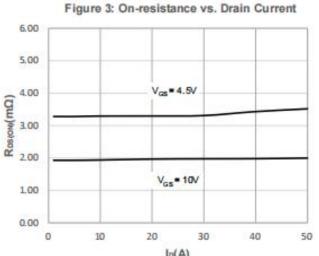
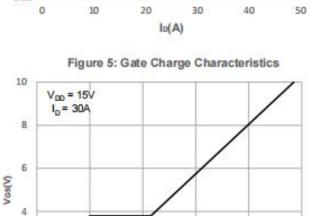
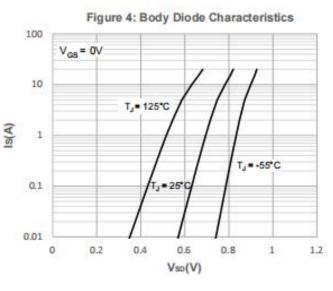


Figure 2: Typical Transfer Characteristics 20 Vos=5V 16 T,= 125°C T,= -55°C 12 10(A) 8 T,= 25°C 4 0 0 0.5 1 1.5 2 2.5 3 3.5 4 4.5 5 5.5 6 Vas(V)







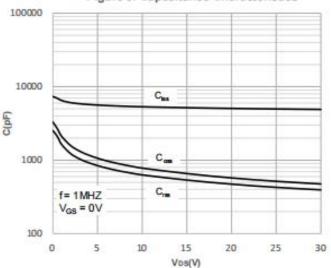


Figure 6: Capacitance Characteristics

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2

0

0

20

40

Qg(nC)

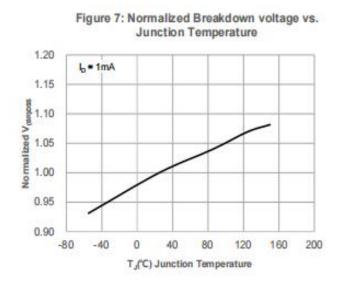
60

80

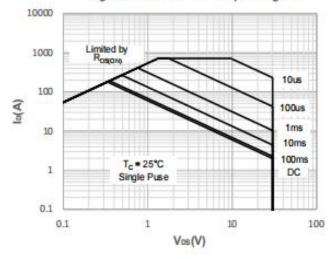
100

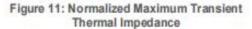
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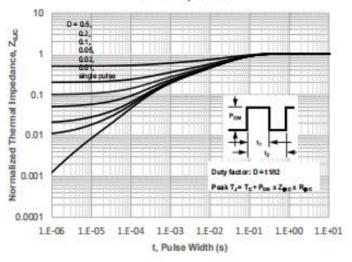












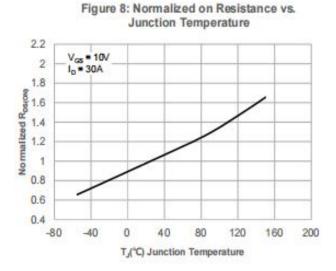


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

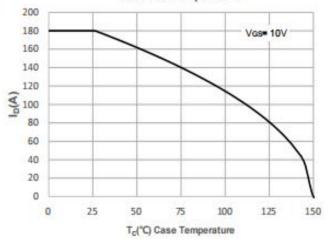
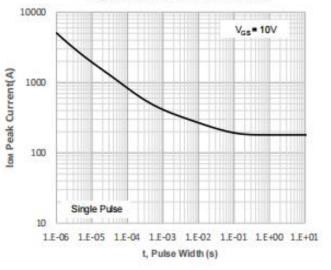
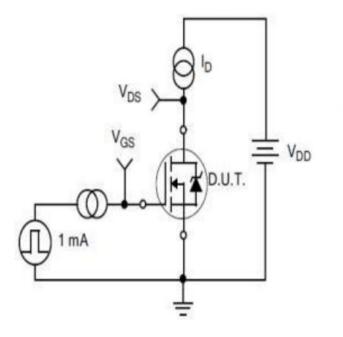


Figure 12: Peak Current Capacity





Test ircuits and Waveforms



VGS(TH)

VDS

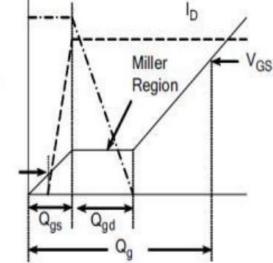


Figure A. Gate Charge Test Circuit

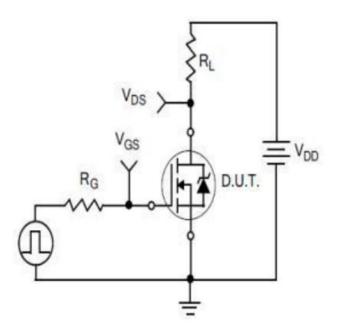


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

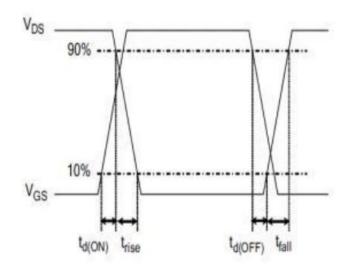
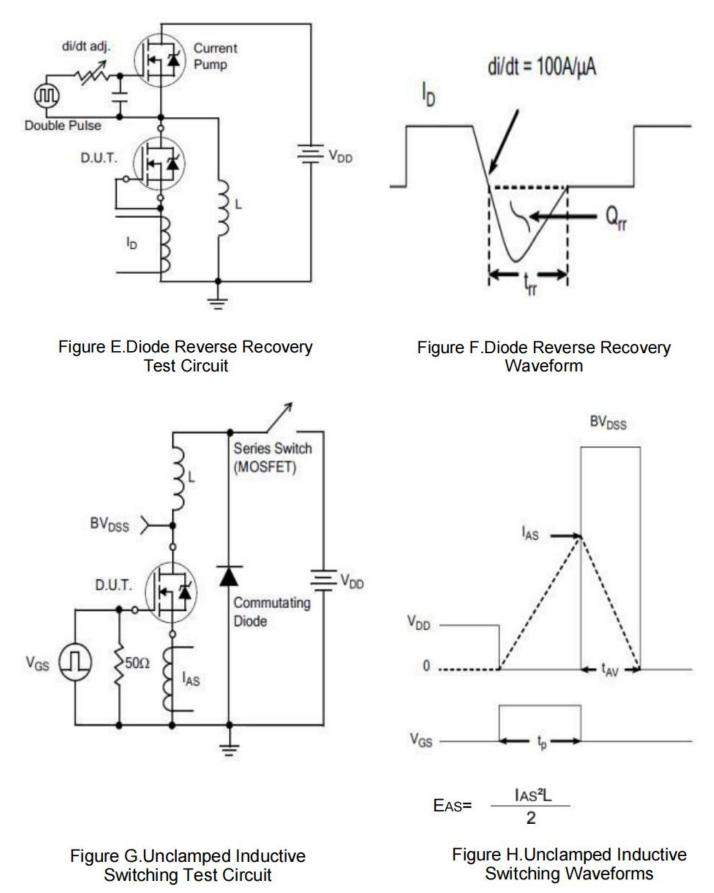


Figure D. Resistive Switching Waveforms

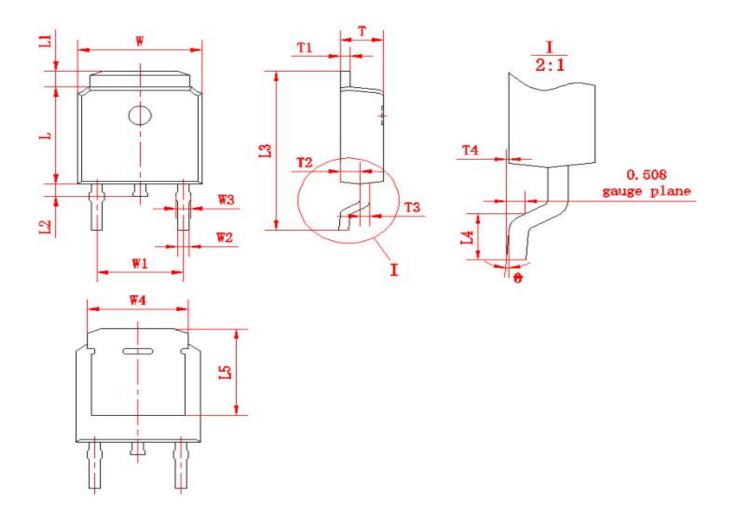


Test ircuits and Waveforms





Package outline drawing(TO-252 Unit: mm)



符号	尺寸		符号	尺寸		符号	尺寸	
C 17	Min	Max	4 <u>7</u> 7	Min	Max	11 7	Min	Max
W	6.50	6.70	L1	0.80	1.20	T1	0.48	0.58
W1	V1 (4.572)		L2	0.60	1.00	T2	0.95	1.15
W2	0.6	0.8	L3	9.70	10.30	Т3	0.48	0.58
W3	0.68	0.88	L4	1.30	1.70	T4	0.00	0.12
W4	(5	.3)	L5	(5.20)		0	0	8
L	6.00	6.20	Т	2.20	2.40			



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